

AON2410

30V N-Channel MOSFET

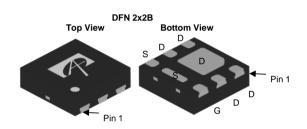
General Description

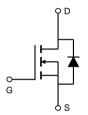
The AON2410 combines advanced trench MOSFET technology with a low resistance package to provide extremely low $R_{\text{DS(ON)}}$. This device is ideal for load switch and battery protection applications.

Product Summary

 $\begin{array}{ll} V_{DS} & 30V \\ I_{D} \; (at \; V_{GS} \! = \! 4.5V) & 8A \\ R_{DS(ON)} \; (at \; V_{GS} = 4.5V) & < 21 m\Omega \\ R_{DS(ON)} \; (at \; V_{GS} = 2.5V) & < 28 m\Omega \end{array}$







Absolute Maximum Ratings T _A =25°C unless otherwise noted							
Parameter		Symbol	Maximum	Units			
Drain-Source Voltage		V_{DS}	30	V			
Gate-Source Voltage		V_{GS}	±12	V			
Continuous Drain T _A =25°C			8	۸			
Current ^G	T _A =70°C	'D	6	A			
Pulsed Drain Current ^C		I _{DM}	32	A			
	T _A =25°C		2.8	W			
Power Dissipation A	T _A =70°C	P _D	1.8	VV			
Junction and Storage Temperature Range		T_J, T_{STG}	-55 to 150	°C			

Thermal Characteristics							
Parameter		Symbol	Тур	Тур Мах			
Maximum Junction-to-Ambient A	t ≤ 10s		37	45	°C/W		
Maximum Junction-to-Ambient AD	Steady-State	$\kappa_{ heta JA}$	66	80	°C/W		



Electrical Characteristics (T_{.1}=25°C unless otherwise noted)

Symbol	Parameter	Conditions		Min	Тур	Max	Units
STATIC P	PARAMETERS						
BV _{DSS}	Drain-Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	I _D =250μA, V _{GS} =0V				V
I _{DSS}	Zoro Gato Voltago Drain Current	V_{DS} =30V, V_{GS} =0V				1	
	Zero Gate Voltage Drain Current		T _J =55°C			5	μА
I _{GSS}	Gate-Body leakage current	V_{DS} =0V, V_{GS} =±12V				±100	nA
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}$, $I_{D}=250\mu A$		0.6	1.07	1.5	V
I _{D(ON)}	On state drain current	V_{GS} =4.5V, V_{DS} =5V		32			Α
	Static Drain-Source On-Resistance	V_{GS} =4.5V, I_D =8A			17.1	21	m()
R _{DS(ON)}			T _J =125°C		26	32	mΩ
		V_{GS} =2.5V, I_D =4A			21.2	28	mΩ
g _{FS}	Forward Transconductance	$V_{DS}=5V$, $I_{D}=8A$			50		S
V_{SD}	Diode Forward Voltage	I _S =1A,V _{GS} =0V			0.7	1	V
Is	Maximum Body-Diode Continuous Current					3.5	Α
DYNAMIC	PARAMETERS						
C _{iss}	Input Capacitance	V _{GS} =0V, V _{DS} =15V, f=1MHz			813		pF
Coss	Output Capacitance				98		pF
C _{rss}	Reverse Transfer Capacitance				56		pF
R_g	Gate resistance	V _{GS} =0V, V _{DS} =0V, f=1MHz			2.3	3.5	Ω
SWITCHII	NG PARAMETERS				-		
Q_g	Total Gate Charge	V _{GS} =4.5V, V _{DS} =15V, I _D =8A			8	12	nC
Q_{gs}	Gate Source Charge				1.2		nC
Q_{gd}	Gate Drain Charge				2.6		nC
t _{D(on)}	Turn-On DelayTime				3		ns
t _r	Turn-On Rise Time	V_{GS} =4.5V, V_{DS} =15V, R_L =1.8 Ω , R_{GEN} =3 Ω			3		ns
t _{D(off)}	Turn-Off DelayTime				26		ns
t _f	Turn-Off Fall Time				3.5		ns
t _{rr}	Body Diode Reverse Recovery Time	I _F =8A, dI/dt=100A/μs	I _F =8A, dI/dt=100A/μs		10		ns
Q _{rr}	Body Diode Reverse Recovery Charge	I _F =8A, dI/dt=100A/μs			2.4		nC

A. The value of $R_{\theta,JA}$ is measured with the device mounted on $1in^2$ FR-4 board with 2oz. Copper, in a still air environment with T_A =25° C. The Power dissipation P_{DSM} is based on $R_{\theta,JA}$ t \leq 10s value and the maximum allowed junction temperature of 150° C. The value in any given application depends on the user's specific board design.

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B. The power dissipation P_D is based on $T_{J_{(MAX)}}$ =150° C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Repetitive rating, pulse width limited by junction temperature $T_{J(MAX)}$ =150° C. Ratings are based on low frequency and duty cycles to keep initial T_J =25° C.

D. The $R_{\theta JA}$ is the sum of the thermal impedance from junction to case $R_{\theta JC}$ and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.

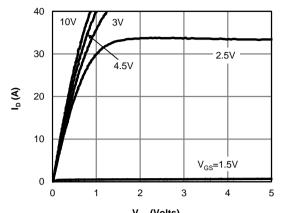
F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of $T_{J(MAX)}$ =150° C. The SOA curve provides a single pulse rating.

G. The maximum current rating is package limited.

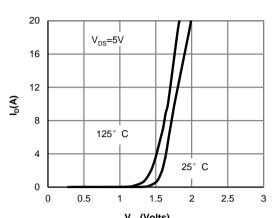
H. These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with T_A=25° C.



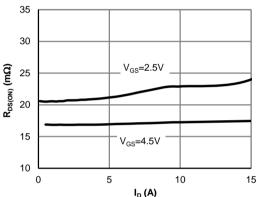
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



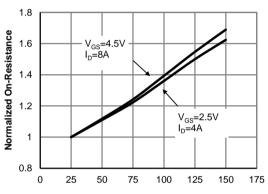
V_{DS} (Volts) Fig 1: On-Region Characteristics (Note E)



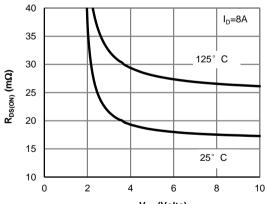
V_{GS}(Volts)
Figure 2: Transfer Characteristics (Note E)



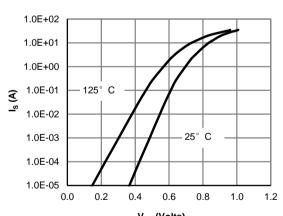
I_D (A) Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)



Temperature (°C)
Figure 4: On-Resistance vs. Junction
Temperature (Note E)



V_{GS} (Volts) Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)



V_{SD} (Volts) Figure 6: Body-Diode Characteristics (Note E)



TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

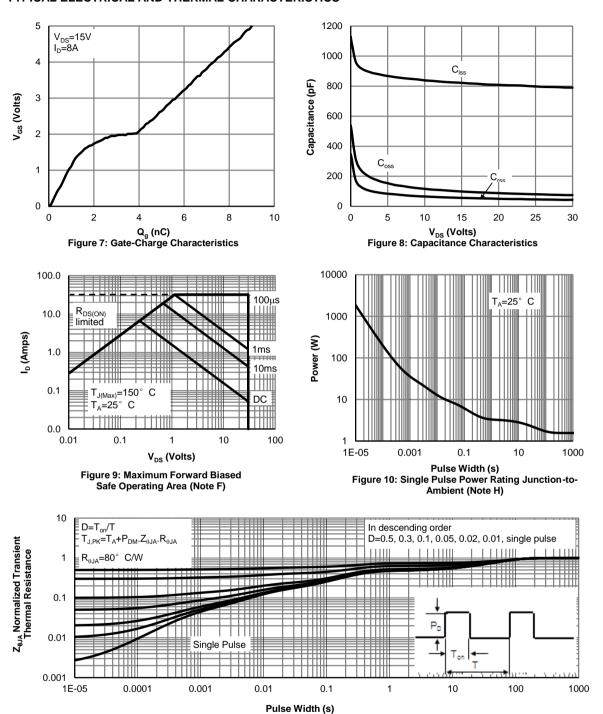
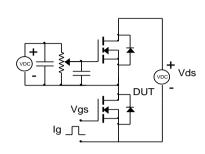
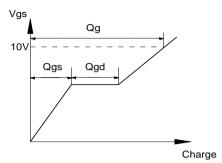


Figure 11: Normalized Maximum Transient Thermal Impedance (Note H)

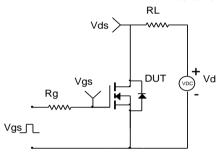


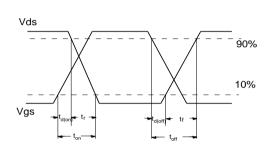
Gate Charge Test Circuit & Waveform



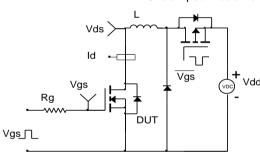


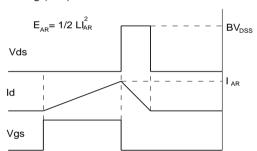
Resistive Switching Test Circuit & Waveforms





Unclamped Inductive Switching (UIS) Test Circuit & Waveforms





Diode Recovery Test Circuit & Waveforms

